

WM2HA016120K

N-Channel SiC Power MOSFET

G2 MOSFET Technology

V_{DS}	=	1200	V
$R_{DS(on)}$	=	16	m Ω
$I_D@25^{\circ}\text{C}$	=	120	A

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive

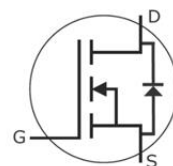
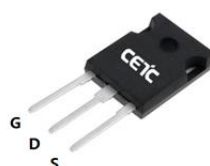
Benefits

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Solar and UPS inverters
- EV motor drive
- High voltage DC/DC converters
- Switched mode power supplies
- Load switch

Package



Part Number	Package	Marking
WM2HA016120K	TO-247-3	WM2HA016120K

Maximum Ratings ($T_c=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain-Source Voltage	1200	V	$V_{GS}=0V, I_D=100\mu A$	
V_{GSmax}	Gate-Source Voltage	-8/+22	V	Absolute maximum values	
V_{GSop}	Gate-Source Voltage	-4/+18	V	Recommended operational values	
I_D	Continuous Drain Current	120	A	$V_{GS}=18V, T_c=25^{\circ}\text{C}$	Fig. 19
		85		$V_{GS}=18V, T_c=100^{\circ}\text{C}$	
$I_{D(pulse)}$	Pulsed Drain Current	250	A	Pulse width t_p limited by T_{Jmax}	Fig. 22
P_D	Power Dissipation	375	W	$T_c=25^{\circ}\text{C}, T_J=175^{\circ}\text{C}$	Fig. 20
T_J, T_{STG}	Operating Junction and Storage Temperature	-55 to +175	$^{\circ}\text{C}$		
T_L	Solder Temperature, 1.6mm from case for 10s	260	$^{\circ}\text{C}$		
M_d	Mounting Torque, (M3 or 6-32 screw)	1	Nm		
		8.8	lbf-in		

Electrical Characteristics ($T_c=25^{\circ}\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200	/	/	V	$V_{GS}=0V, I_D=100\mu A$	
$V_{GS(th)}$	Gate Threshold Voltage	1.9	2.6	4.0	V	$V_{DS}=V_{GS}, I_D=23mA$	Fig. 11
		/	1.8	/		$V_{DS}=V_{GS}, I_D=23mA, T_J=175^{\circ}\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current	/	1	100	μA	$V_{DS}=1200V, V_{GS}=0V$	
I_{GSS+}	Gate-Source Leakage Current	/	10	250	nA	$V_{DS}=0V, V_{GS}=22V$	
I_{GSS-}	Gate-Source Leakage Current	/	10	250	nA	$V_{DS}=0V, V_{GS}=-8V$	
$R_{DS(on)}$	Drain-Source On-State Resistance	/	16	22.3	m Ω	$V_{GS}=18V, I_D=75A$	Fig. 4,5,6
		/	28	/		$V_{GS}=18V, I_D=75A, T_J=175^{\circ}\text{C}$	
g_{fs}	Transconductance	/	41.4	/	S	$V_{DS}=20V, I_{DS}=75A$	Fig. 7
		/	36.5	/		$V_{DS}=20V, I_{DS}=75A, T_J=175^{\circ}\text{C}$	
C_{iss}	Input Capacitance	/	4817	/	pF	$V_{GS}=0V$	Fig. 17,18
C_{oss}	Output Capacitance	/	207	/		$V_{DS}=1000V$	
C_{rss}	Reverse Transfer Capacitance	/	45	/		$f=1MHz$	
E_{oss}	C_{oss} Stored Energy	/	104	/	μJ	$V_{AC}=25mV$	Fig. 16
E_{ON}	Turn-On Switching Energy	/	2.1	/	mJ	$V_{DS}=800V, V_{GS}=-4V/18V$	
E_{OFF}	Turn-Off Switching Energy	/	1.6	/		$I_D=30A, R_{G(ext)}=2.5\Omega, L=100\mu H$	
$t_{d(on)}$	Turn-On Delay Time	/	150	/	ns	$V_{DS}=800V, V_{GS}=-4V/18V, I_D=30A$ $R_{G(ext)}=2.5\Omega, R_L=20\Omega$	
t_r	Rise Time	/	38	/			
$t_{d(off)}$	Turn-Off Delay Time	/	108	/			
t_f	Fall Time	/	35	/			
$R_{G(int)}$	Internal Gate Resistance	/	4.5	/	Ω	$f=1MHz, V_{AC}=25mV$	
Q_{GS}	Gate to Source Charge	/	66	/	nC	$V_{DS}=800V$	Fig. 12
Q_{GD}	Gate to Drain Charge	/	48	/		$V_{GS}=-4V/18V$	
Q_G	Total Gate Charge	/	269	/		$I_D=30A$	

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.2	/	V	$V_{GS}=-4V, I_{SD}=37.5A, T_J=25^{\circ}\text{C}$	Fig. 8,9,10
		3.9	/		$V_{GS}=-4V, I_{SD}=37.5A, T_J=175^{\circ}\text{C}$	
I_S	Continuous Diode Forward Current	/	120	A	$T_c=25^{\circ}\text{C}$	
t_{rr}	Reverse Recover Time	54	/	ns	$V_R=800V, I_{SD}=30A$	
Q_{rr}	Reverse Recovery Charge	630	/	nC		
I_{rrm}	Peak Reverse Recovery Current	19	/	A		

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.23	/	$^{\circ}\text{C/W}$		Fig. 21
$R_{\theta JA}$	Thermal Resistance from Junction to Ambient	/	40			

Typical Performance

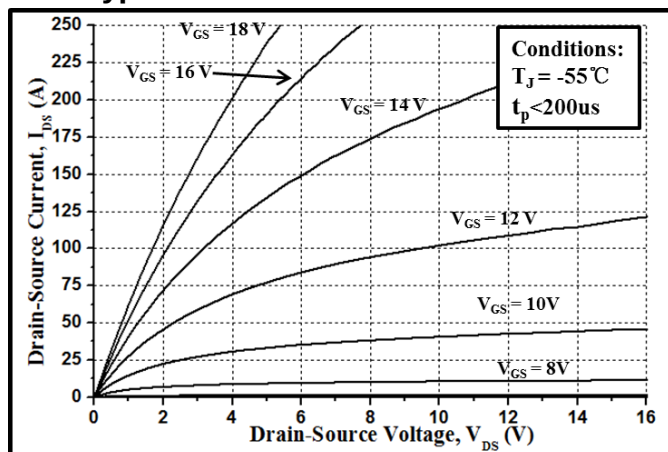


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

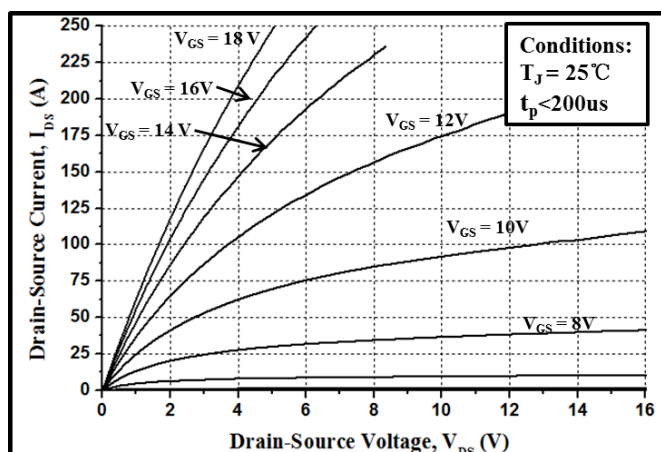


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

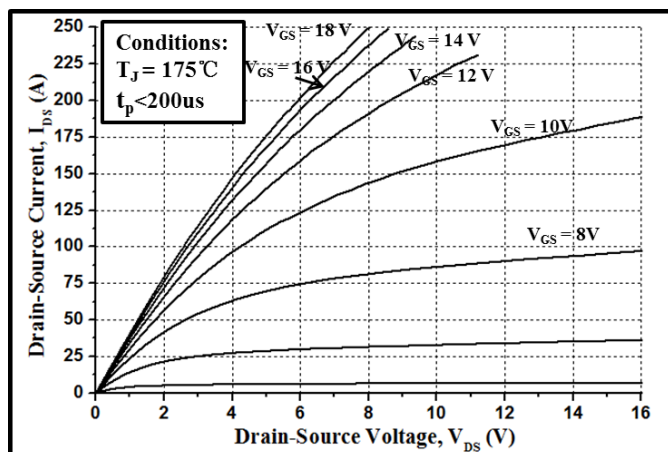


Figure 3. Output Characteristics $T_J = 175^\circ\text{C}$

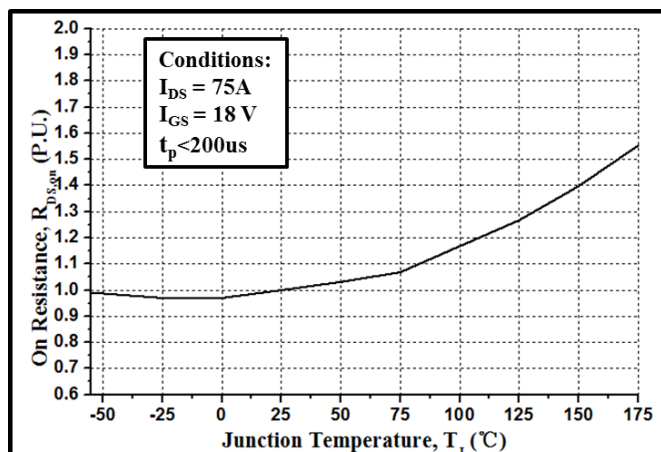


Figure 4. Normalized On-Resistance vs. Temperature

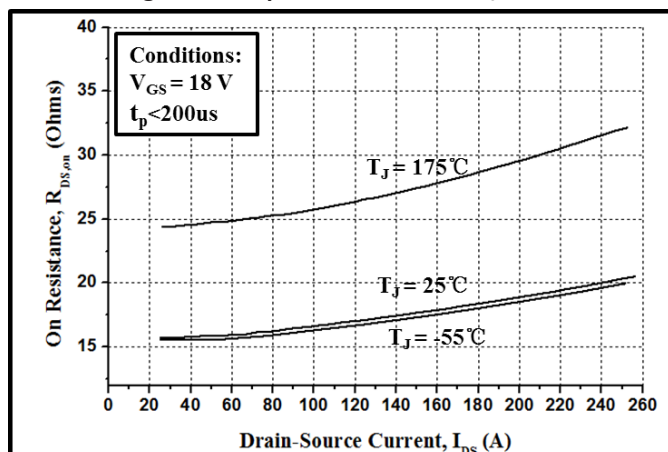


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

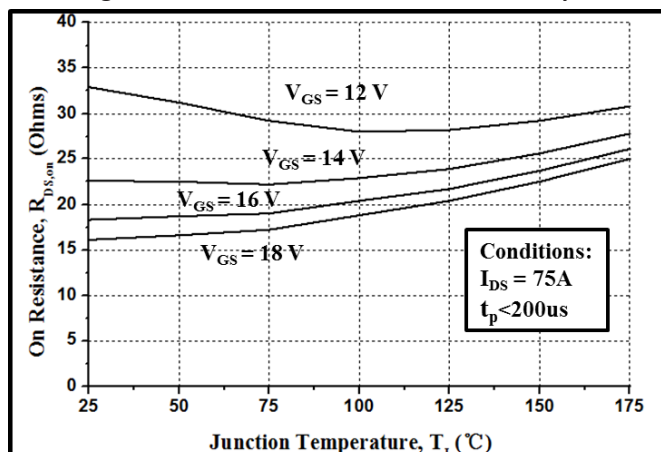


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

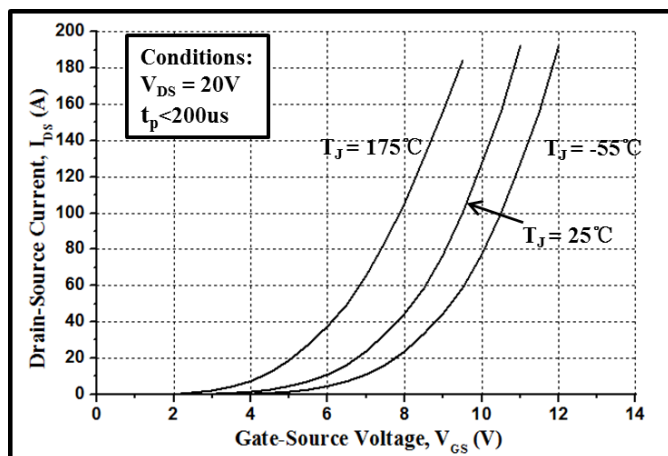


Figure 7. Transfer Characteristic for Various Junction Temperatures

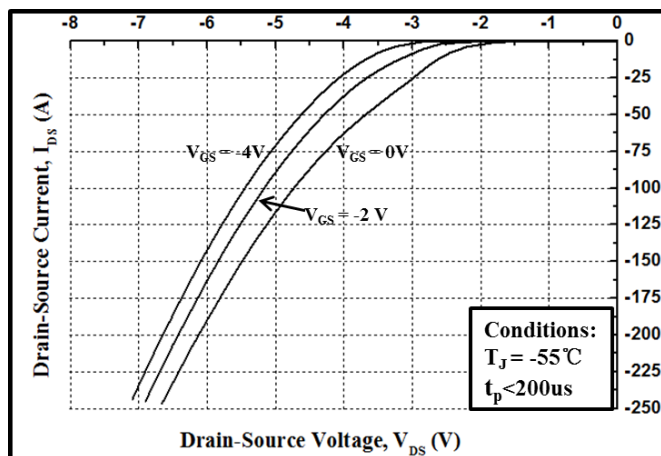


Figure 8. Body Diode Characteristic at -55°C

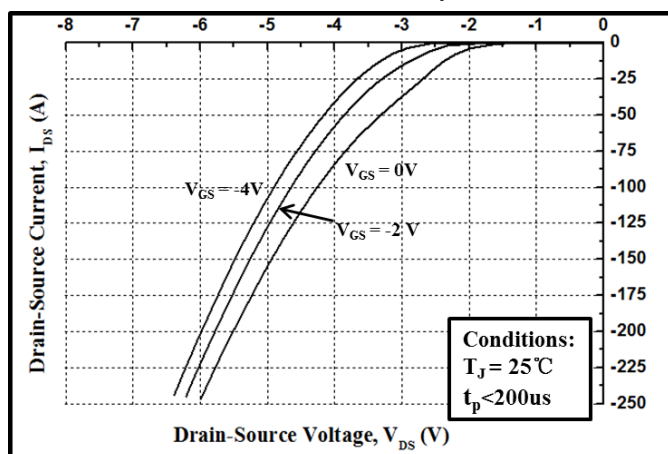


Figure 9. Body Diode Characteristic at 25°C

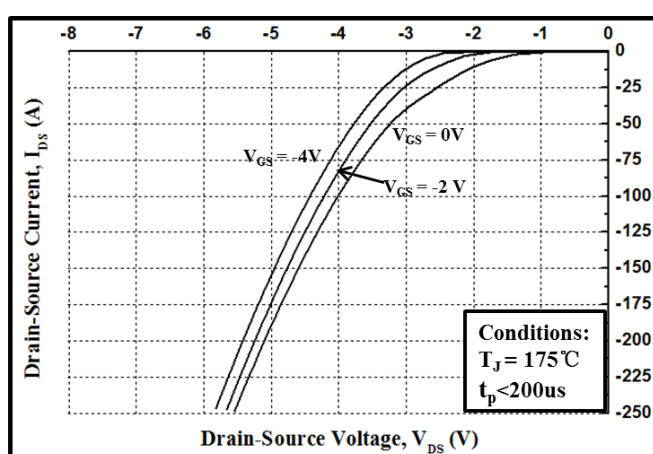


Figure 10. Body Diode Characteristic at 175°C

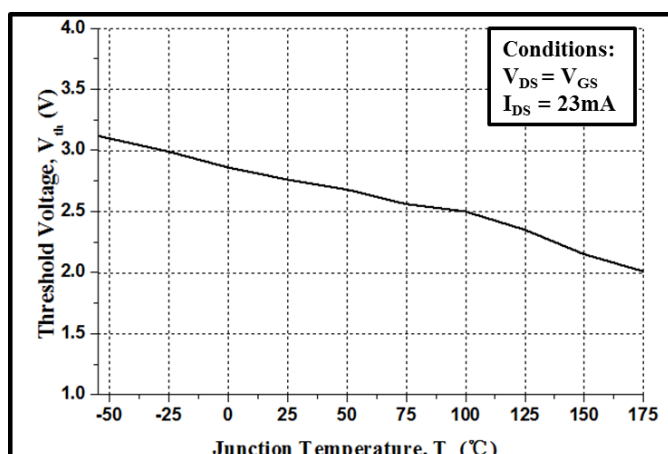


Figure 11. Threshold Voltage vs. Temperature

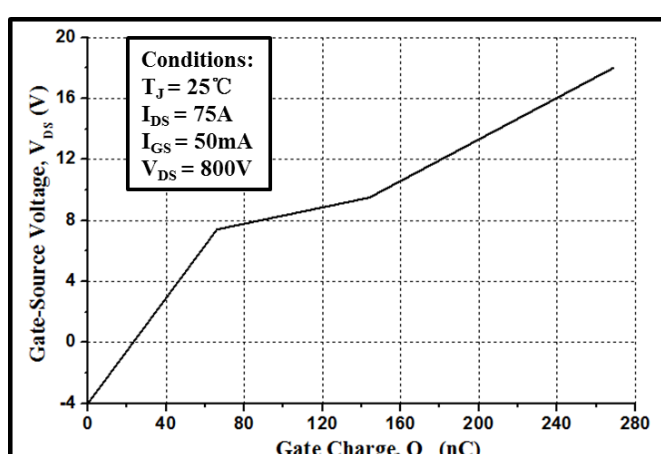


Figure 12. Gate Charge Characteristics

Typical Performance

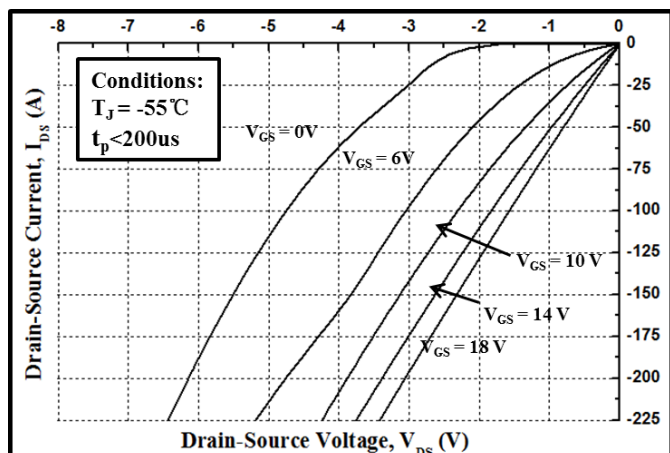


Figure 13. 3rd Quadrant Characteristic at -55°C

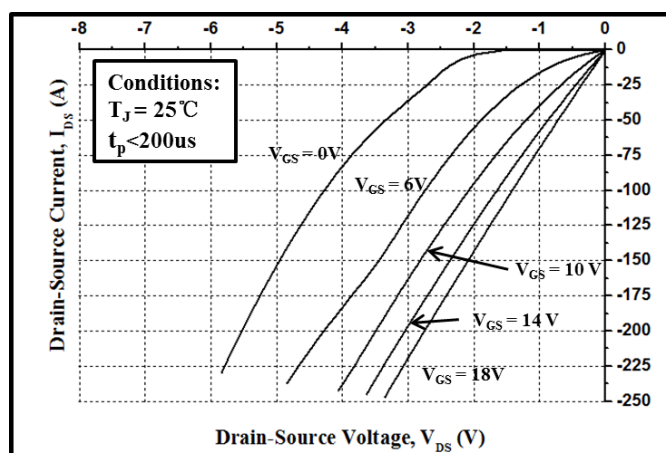


Figure 14. 3rd Quadrant Characteristic at 25°C

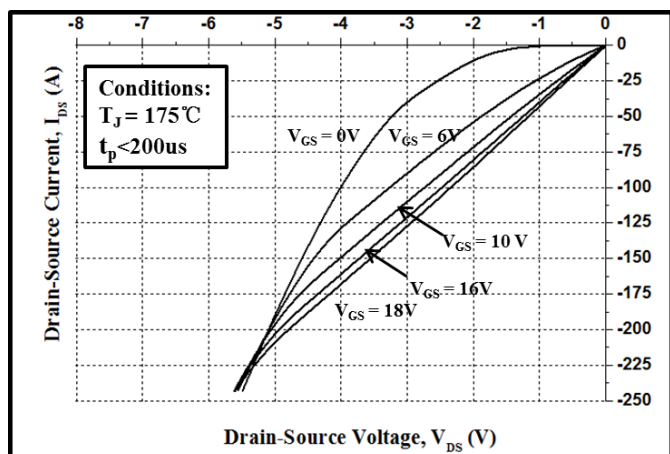


Figure 15. 3rd Quadrant Characteristic at 175°C

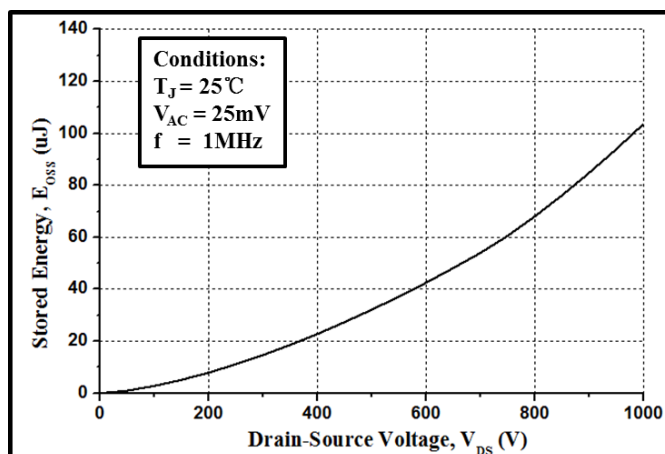


Figure 16. Output Capacitor Stored Energy

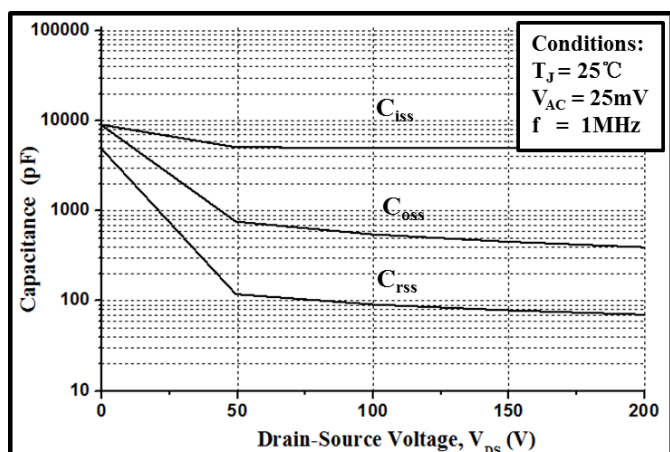


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

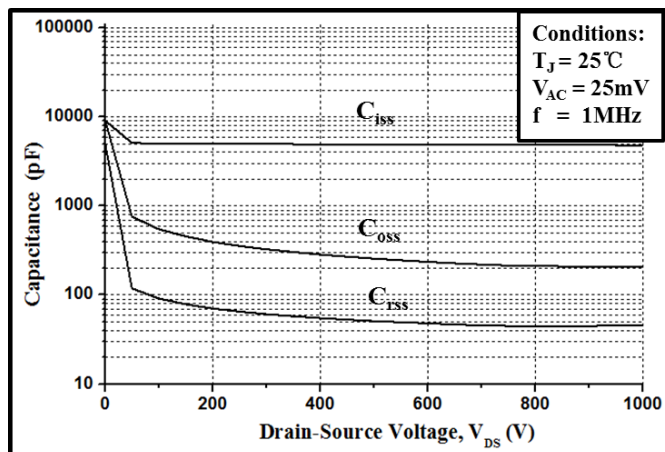


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

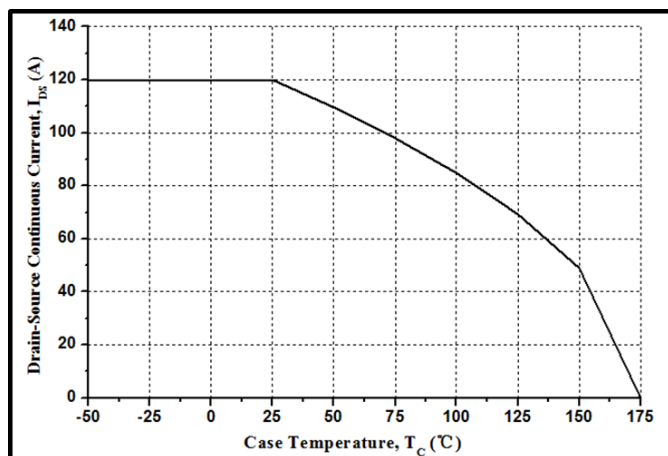


Figure 19. Continuous Drain Current vs. Case Temperature

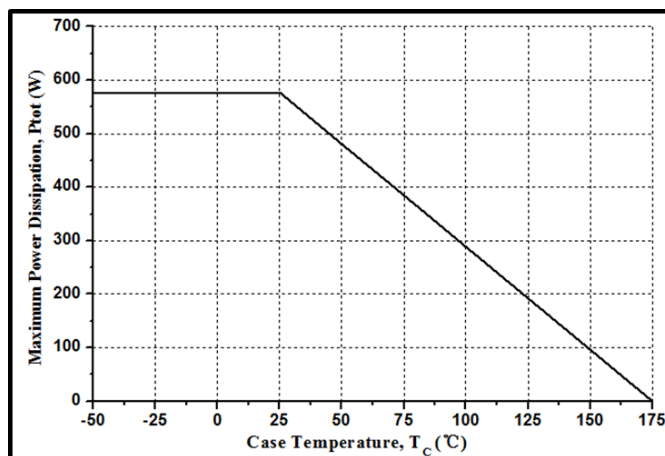


Figure 20. Maximum Power Dissipation vs. Case Temperature

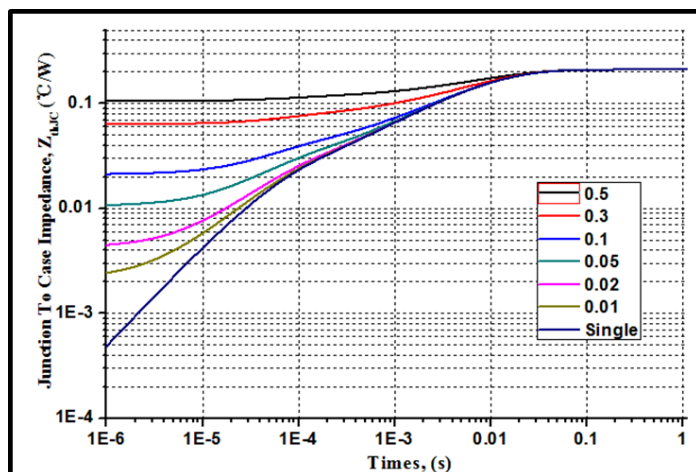


Figure 21. Transient Thermal Impedance (Junction - Case)

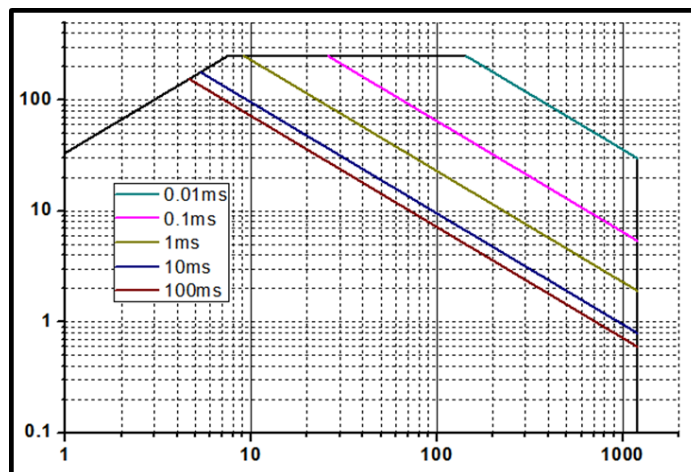


Figure 22. Safe Operating Area

Test Circuit Schematic

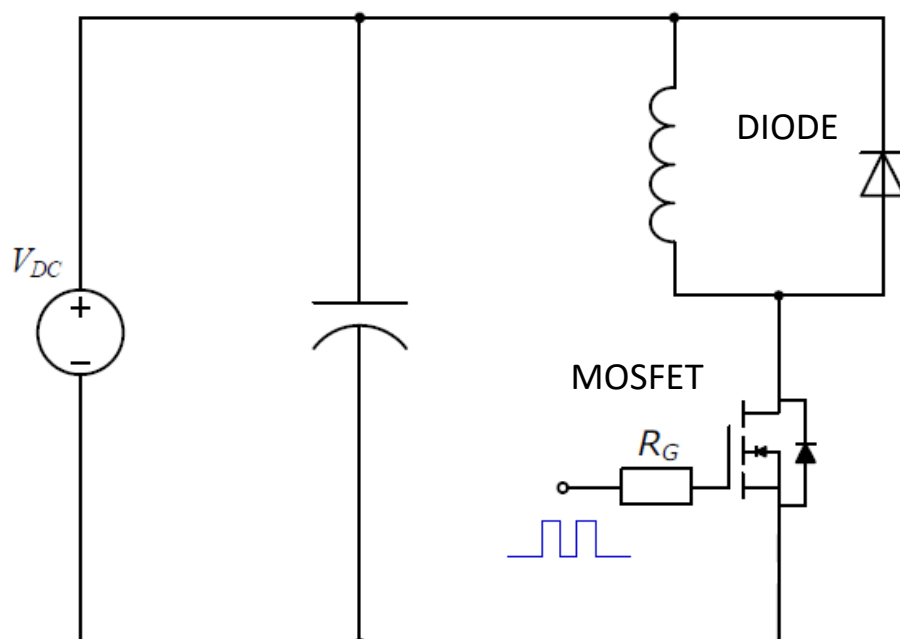
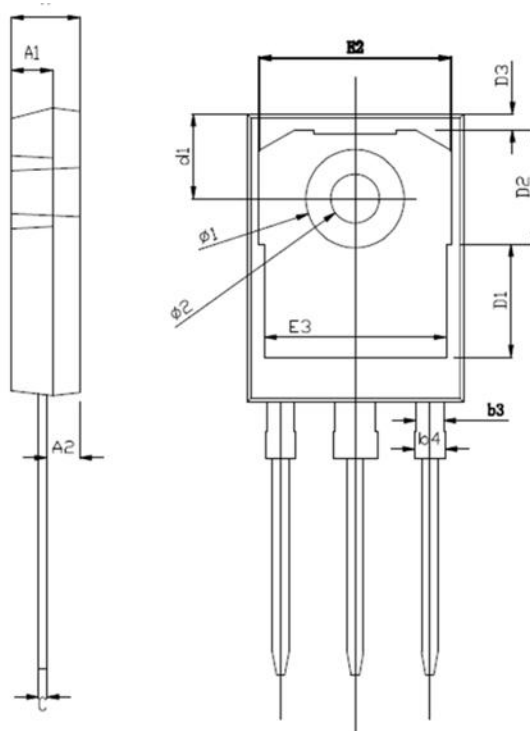
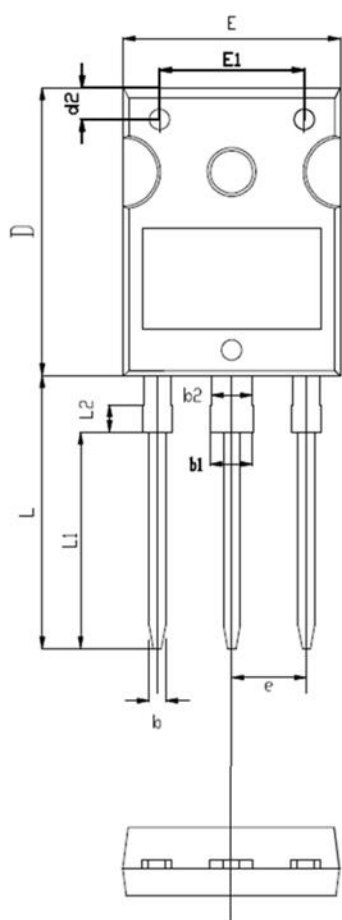
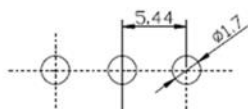


Figure 23. Clamped Inductive Switching
Waveform Test Circuit

Package Dimensions



RECOMMENDED LAND PATTERN



UNIT: mm

	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.80	3.00	3.20
A2	2.26	2.41	2.56
b	1.10	1.20	1.30
b1	2.90	-	3.20
b2	2.90	3.00	3.10
b3	1.90	2.00	2.10
b4	2.00	-	2.20
c	0.50	0.60	0.70
D	20.80	21.00	21.20
D1		8.23	
D2		8.32	
D3		1.17	
d1	6.00	6.15	6.30
d2	2.20	2.30	2.40
E	15.60	15.80	16.00
E1		10.50	
E2		14.02	
E3		13.50	
e	5.34	5.44	5.54
L	19.72	19.92	20.12
L1		15.79	
L2		1.98	
ø1	7.10	7.19	7.30
ø2	3.50	3.60	3.70

Notes

- 1) Before using our products, please contact our marketing managers and get the latest specifications.
- 2) Ongoing efforts are being made to improve the reliability and quality of the products by CETC, but the semiconductors can malfunction due to various factors. Therefore, in order to prevent artificial damage or fire arising from failure, please take safety measures such as complying with the derating characteristics, implementing redundant and fire prevention designs, and utilizing backups and fail-safe procedures. CETC doesn't have responsibility for any damages arising from the use of our products beyond the rating specified by CETC.
- 3) All the information contained in this document, such as the examples of application circuits, circuit constants, is provided only to illustrate the standard usage and operations of the products. The other relevant conditions must be taken into consideration when designing circuits for mass production.
- 4) The information specified in this document is intended only to show the typical functions and examples of application circuits for the products. CETC does not grant you, explicitly or implicitly, any license to use or exercise intellectual property or other rights held by CETC or any other parties. CETC shall have no responsibility whatsoever for any dispute arising from the use of such technical information.
- 5) The products specified in this document are not designed to be radiation tolerant.
- 6) For use of our products in applications requiring a high degree of reliability (as exemplified below), please contact and consult with a CETC representative: transportation equipment (cars, ships, trains, etc.), primary communication equipment, traffic lights, fire/crime prevention, safety equipment, medical systems, and power transmission systems.
- 7) Do not use our products in applications requiring extremely high reliability, such as aerospace equipment, nuclear power control systems and submarine repeaters.
- 8) CETC shall not be responsible for any damages or injury caused by non-compliance with the recommended usage conditions and specifications contained in this document.
- 9) CETC has used reasonable care to ensure the accuracy of the information contained in this document. However, CETC does not guarantee the information contained in this document is totally correct, and CETC doesn't have responsibility for any damages arising from any inaccuracy or misprint of such information.
- 10) Please use the products in accordance with any applicable environmental laws and regulations, such as the RoHS Directive. For more details, including RoHS compatibility, please contact a CETC marketing manager. CETC doesn't have responsibility for any damages or losses arising from disobedience to any relevant laws or regulations.
- 11) When providing our products and technologies contained in this document to other countries or regions, you must comply with the procedures and provisions stipulated by all the applicable export laws and regulations, including but not limited to the relevant laws or regulations.
- 12) The information contained in this document is subject to change without notice.
- 13) Neither part nor all of this file is allowed to be reprinted or reproduced without authorization of CETC.
- 14) CETC reserves the right to the final interpretation.